## Notice of References Cited

Application/Control No.	Applicant(s)/Patent Under				
10/616,344	Reexamination IWAMURA, RYUICHI				
Examiner	Art Unit				
Salvador E. Rivas	2616	Page 1 of 1			

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0184427 A1	09-2004	Lynch et al.	370/342
*	<b>B</b> :	US-6,064,662	05-2000	Gitlin et al.	370/330
*	С	US-2003/0039317 A1	02-2003	Taylor et al.	37,5/295
*	D	US-6,356,555 B1	03-2002	Rakib et al.	370/441
*	E	US-7,212,564 B2	05-2007	Parizhsky et al.	375/144
*	F	US-6,442,129 B1	08-2002	Yonge et al.	. 370/204
*	G	US-6,826,160 B1	11-2004	Wang et al.	370/329
	Н	US-			
	l	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-		•	

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					·
	0					·
	Р					
	Q	·				
	R					
	S	•				
•	Т					

## NON-PATENT DOCUMENTS

		THE REST OF THE PARTY.	nio Bato, i abilorio,	, Lattorior Volume	, Pertinent Pages)	
	<u> </u>					
/						
1	•		·			
			· · · · · · · · · · · · · · · · · · ·			
	•	·				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.